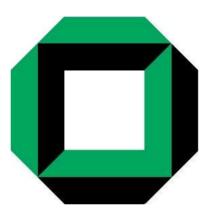
Plug Electron ID using Neural Network techniques



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EWK meeting

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Variables for plug electron ID

- ◆ Fiducial cut: 1.2 < |eta| < 2.8
 ♦ EmE_T
- HadE/EmE (sliding cut)
- Isolation Ratio
- PEM χ^2 (comparison with test beam data)
- PES 5by9 u/v (Shower profile in PES in u and v direction)

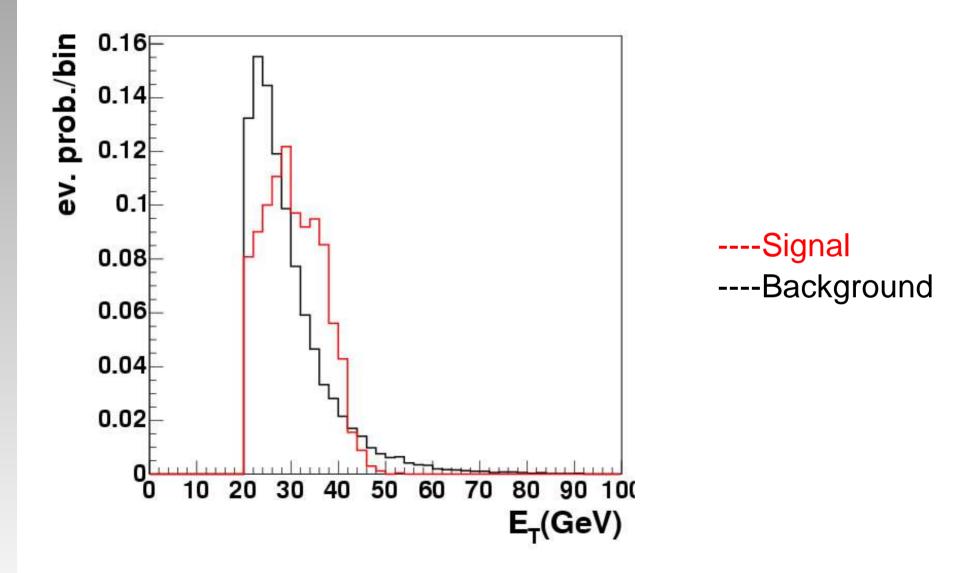
Selection of the samples

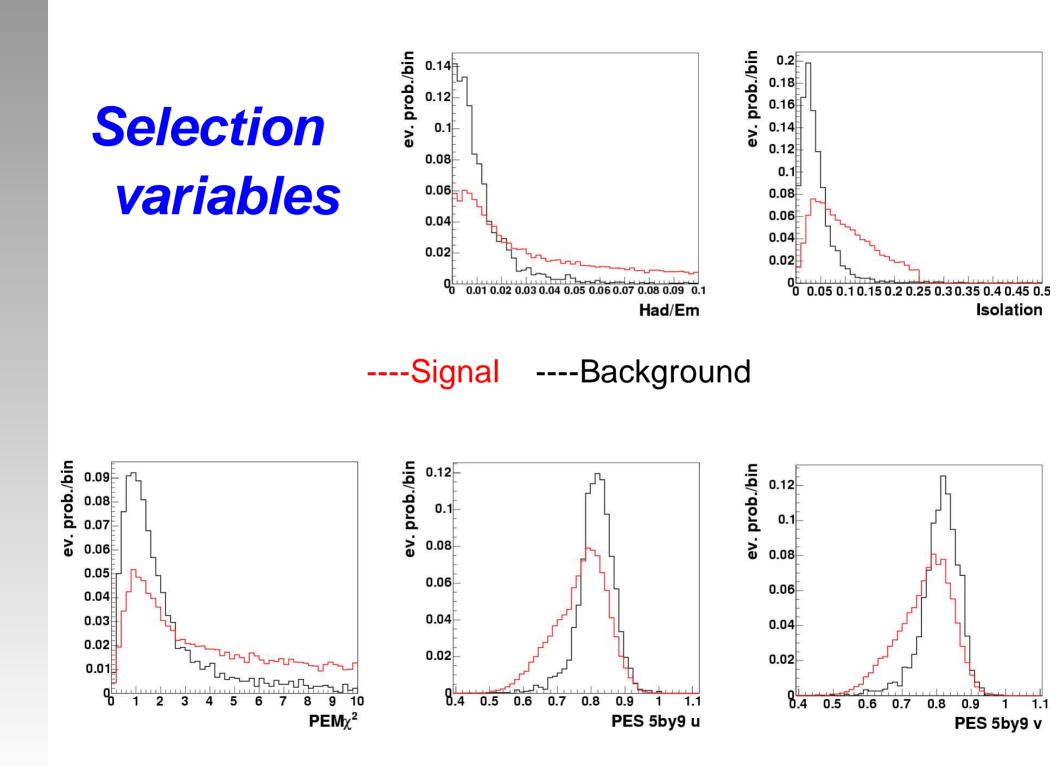
• <u>Signal sample:</u>

- 1 tight central electron
- Another electron candidate in plug (Z-Candidate)
- Cut to be independent of trigger cuts
- ~3000 events remain
- Background sample:
 - 2 balanced jets (1 central, 1 plug)
 - Several preselection cuts
 - ~15000 events remain

Both samples taken from data! (bpel08)

Control plot: E_{τ} of plug electron





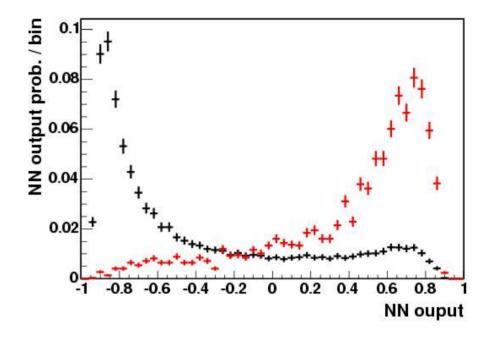


	Signal		Backgr	round
Total	2926	100.00%	15133	100.00%
Plug-e:HadEm < .05+0.026ln(EmE/100)	2884	98.53%	12147	80.27%
lso < 0.1	2740	93.64%	7364	48.66%
PEM Chi2 < 10	2496	85.30%	5132	33.91%
PES 5by9 u >0.65	2468	84.34%	4824	31.88%
PES 5by9 v >0.65	2441	83.42%	4595	30.36%
Comparision with CDF note 6789		84.60%		

Room for optimization?

Artificial Neural Network

♦ 5 variables Had/Em Isolation PEM chi2 PES 5/9 u/v 10 nodes in intermediate layer Binary classification (-1 background, 1 signal) 200 iterations



NN cut	Signal	Backgound
0	84%	21%
-0.3	91%	30%
Cutbased:	84%	30%

Correlation matrix

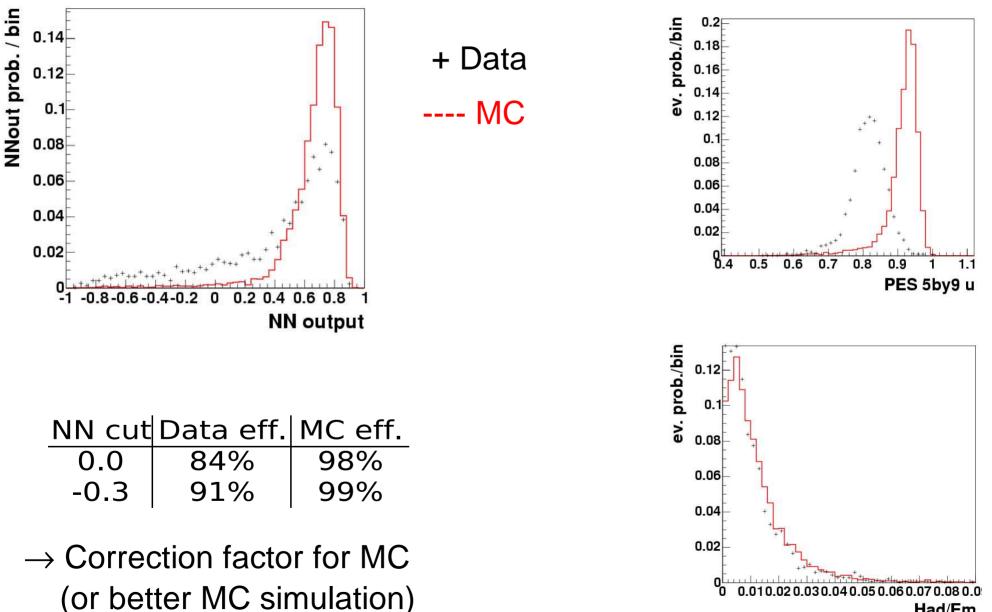
	Target	HadEm	lso	PEM chi2	PES 5/9 u	PES 5/9 v
Target	100.0%	-22.9%	-50.8%	39.2%	29.3%	29.7%
HadEm	-22.9%	100.0%	36.0%	24.2%	-9.6%	-7.7%
lso	-50.8%	36.0%	100.0%	51.6%	-25.4%	-24.2%
PEM chi2	39.2%	24.2%	51.6%	100.0%	-29.3%	-28.6%
PES 5/9 u	29.3%	-9.6%	-25.4%	-29.3%	100.0%	40.7%
PES 5/9 v	29.7%	-7.7%	-24.2%	-28.6%	40.7%	100.0%

Target is -1 for background, 1 for signal

Relevance

Rank	Variable	Correlation (%)	Correlation (sigma)
1	lso	50.80%	57.12
2	PES 5/9 v	17.91%	20.14
3	PEM Chi2	11.93%	13.41
4	PES 5/9 u	9.60%	10.79
5	Had/Em	4.30%	4.83

Data vs MC (quick check)



Had/Em

Conclusion, outlook

Correlations between selection variables
ANN can improve selection and ID

Use more variables
Use tracking information
Test with analysis